TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ( $\pi$ -MOS VI)

# **TK15H50C**

#### ○ Switching Regulator Applications

Unit: mm

• Low drain-source ON resistance :  $R_{DS}$  (ON) = 0. 33  $\Omega$  (typ.)

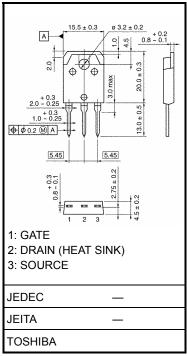
• High forward transfer admittance :  $|Y_{fs}| = 8.5 \text{ S (typ.)}$ 

• Low leakage current :  $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 500 \text{ V)}$ 

• Enhancement mode :  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V}, \text{I}45_{D} = 1 \text{ mA})$ 

### Absolute Maximum Ratings (Ta = 25°C)

Characteri	stic	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	500	V	
Drain-gate voltage (Ro	<sub>GS</sub> = 20 kΩ)	$V_{DGR}$	500	V	
Gate-source voltage		$V_{GSS}$	±30	٧	
Drain current	DC (Note 1)	I <sub>D</sub>	15	А	
	Pulse (Note 1)	$I_{DP}$	60	Α	
Drain power dissipation	n (Tc = 25°C)	P <sub>D</sub>	150	W	
Single-pulse avalanche	e energy (Note 2)	E <sub>AS</sub>	765	mJ	
Avalanche current		I <sub>AR</sub>	15	Α	
Repetitive avalanche e	nergy (Note 3)	E <sub>AR</sub>	15	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature ra	ange	T <sub>stg</sub>	-55~150	°C	



Weight: 3.8 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

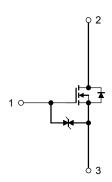
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	0.833	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 5.78 mH,  $R_{G}$  = 25  $\Omega$ ,  $I_{AR}$  = 15 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



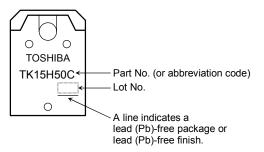
## **Electrical Characteristics (Ta = 25°C)**

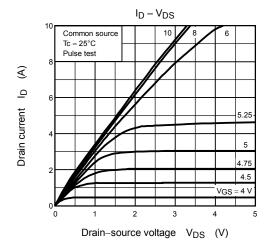
Charac	cteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V	±30	_	_	V
Drain cutoff curr	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	500	_	_	V
Gate threshold v	/oltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.0 A		0.33	0.4	Ω
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.0 A	4.0	8.5	_	S
Input capacitano	е	C <sub>iss</sub>			2450	1	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		15	1	pF
Output capacitance		C <sub>oss</sub>			220	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS} = \frac{10V}{0V} \int_{0V}^{1D=7A} V_{out}$ $V_{GS} = \frac{10V}{0V} \int_{0V}^{1D=7A} V_{out}$ $V_{DD} = \frac{10V}{210V}$ $V_{DD} = \frac{10V}{210V}$ $V_{DD} = \frac{10V}{210V}$	_	50	_	
	Turn-on time	t <sub>on</sub>		_	90	_	20
	Fall time	t <sub>f</sub>		_	45	_	ns
	Turn-off time	t <sub>off</sub>		_	175	_	
Total gate charg plus gate-drain)		Qg		_	48	_	
Gate-source charge Gate-drain ("Miller") charge		Q <sub>gs</sub>	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$	_	26	_	nC
		Q <sub>gd</sub>			22	_	

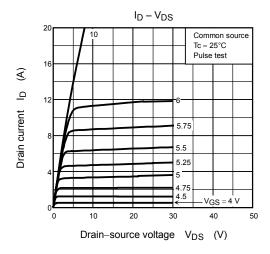
## Source-Drain Ratings and Characteristics (Ta = 25°C)

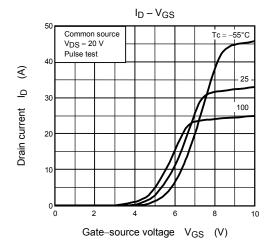
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	-	15	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	60	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 15 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 15 A, V <sub>GS</sub> = 0 V dI <sub>DR</sub> / dt = 100 A / μs	_	1050	1	ns
Reverse recovery charge	Qrr	dl <sub>DR</sub> / dt = 100 A / μs	_	13		μC

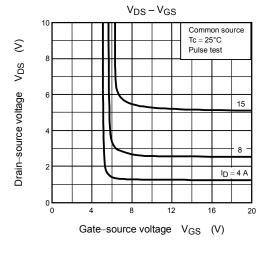
### Marking

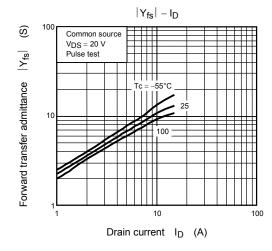


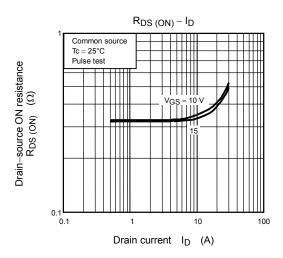


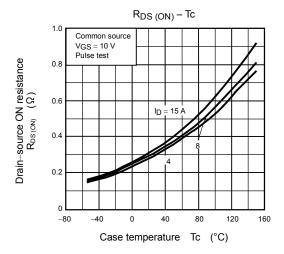


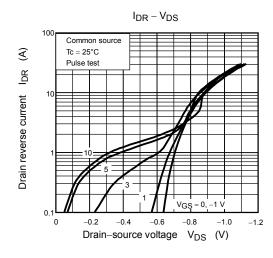


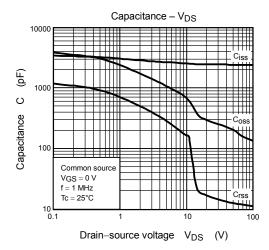


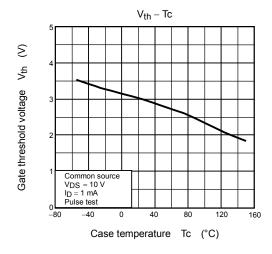


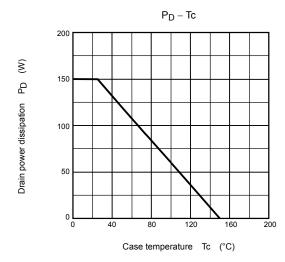


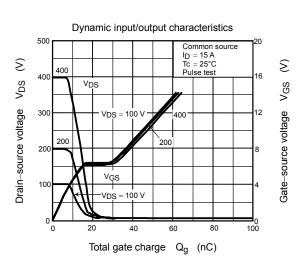


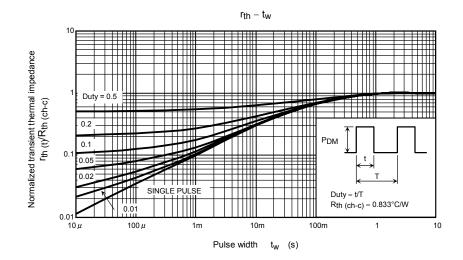




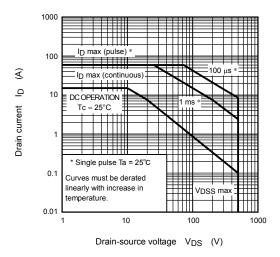


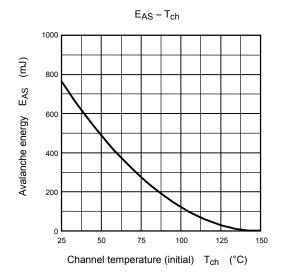


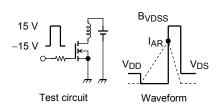












$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 5.78~mH \end{aligned} \qquad \text{E}$$

$$\mathsf{EAS} = \frac{1}{2} \cdot L \cdot l^2 \cdot \left( \frac{\mathsf{BVDSS}}{\mathsf{BVDSS} - \mathsf{VDD}} \right)$$

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